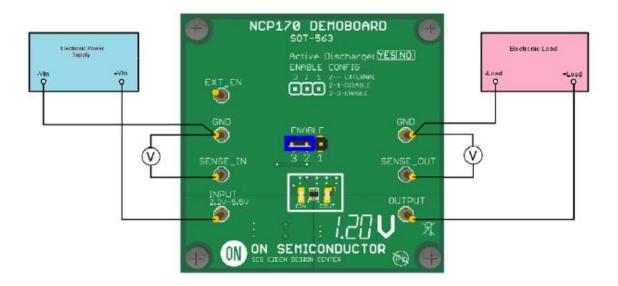
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Test Procedure for the NCP170AXV120GEVB Evaluation Board



Test procedure:

- 1. Check the position of jumper and correct this if necesary in acordance with the picture above.
- 2. Connect the test setup as shown Figure above
- 3. Appy an input voltage Vin = 2.2 V
- 4. Appy Iout = 0mA load.
- 5. Check that Vout is **1.2 V** +/-**1%**.
- 6. Increase lout up to 0.15 A
- 7. Check that Vout is **1.2 V** +/-**1%**.
- 7. Increase Vin up to 5.5 V and decrease the load in accordance with SOA
- 8. Power down the Load
- 9. Power down the Vcc
- 10. End of test